

N-channel TrenchMOS logic level FET Rev. 04 — 31 January 2011

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Q101 compliant

1.3 Applications

- 12 V and 24 V loads
- Automotive and general purpose power switching

1.4 Quick reference data

Table 1 Quick reference data

Table 1.	Quick reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	55	V
I _D	drain current	$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	<u>[1]</u>	-	-	75	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see Figure 2		-	-	253	W
Static cha	aracteristics						
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I _D = 25 A; T _j = 25 °C		-	6.4	7.5	mΩ
		$V_{GS} = 4.5 \text{ V}; \text{ I}_{D} = 25 \text{ A};$ T _j = 25 °C		-	-	8.5	mΩ
		$\label{eq:VGS} \begin{array}{l} V_{GS} = 5 \text{ V}; \text{ I}_{D} = 25 \text{ A}; \\ T_{j} = 25 \text{ °C}; \text{ see } \underline{\text{Figure 11}}; \\ \text{see } \underline{\text{Figure 12}} \end{array}$		-	6.8	8	mΩ



Motors, lamps and solenoids

Suitable for logic level gate drive

Suitable for thermally demanding environments due to 175 °C rating

sources

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Table 1.	Quick reference data	continued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{array}{l} I_D = 75 \; A; \; V_{sup} \leq 55 \; V; \\ R_GS = 50 \; \Omega; \; V_GS = 5 \; V; \\ T_{j(init)} = 25 \; ^{\circ}C; \; unclamped \end{array}$	-	-	670	mJ
Dynamic	characteristics					
Q _{GD}	gate-drain charge	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A};$ $V_{DS} = 44 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 13</u>	-	43	-	nC

[1] Continuous current is limited by package.

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		-
2	D	drain ^[1]	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbbo76 S
			SOT404 (D2PAK)	

[1] It is not possible to make a connection to pin 2.

3. Ordering information

Table 3.Ordering information

Type number	Package		
	Name	Description	Version
BUK9608-55A	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

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4. Limiting values

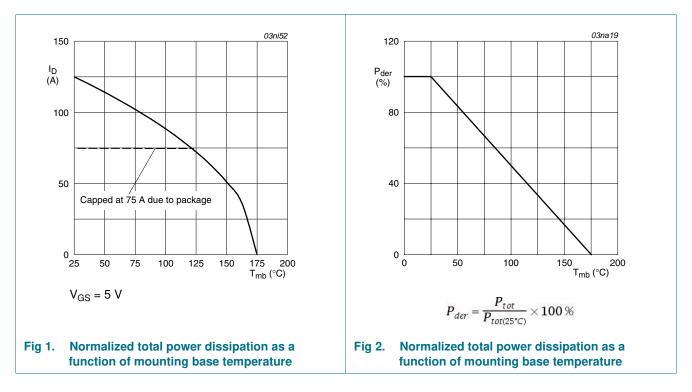
Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	55	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	55	V
V _{GS}	gate-source voltage			-15	15	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 5 \text{ V}; \text{ see } \frac{\text{Figure 1}}{\text{Figure 1}};$	[1]	-	125	А
		see <u>Figure 3</u>	[2]	-	75	А
		T_{mb} = 100 °C; V_{GS} = 5 V; see <u>Figure 1</u>	[2]	-	75	А
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \ \mu s$; see Figure 3		-	503	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	253	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drai	n diode					
I _S	source current	T _{mb} = 25 °C	<u>[1]</u>	-	125	А
			[2]	-	75	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	503	А
Avalanche r	uggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 75 A; V_{sup} ≤ 55 V; R_{GS} = 50 Ω; V_{GS} = 5 V; $T_{i(init)}$ = 25 °C; unclamped		-	670	mJ

[1] Current is limited by power dissipation chip rating.

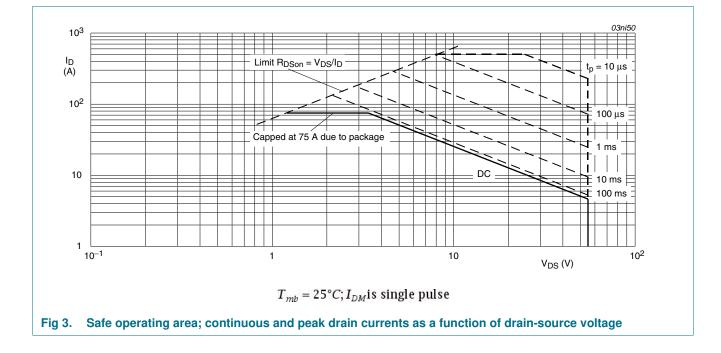
[2] Continuous current is limited by package.



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Thermal characteristics 5.

Table 5.	Inermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.59	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	mounted on a printed-circuit board ; minimum footprint	-	50	-	K/W

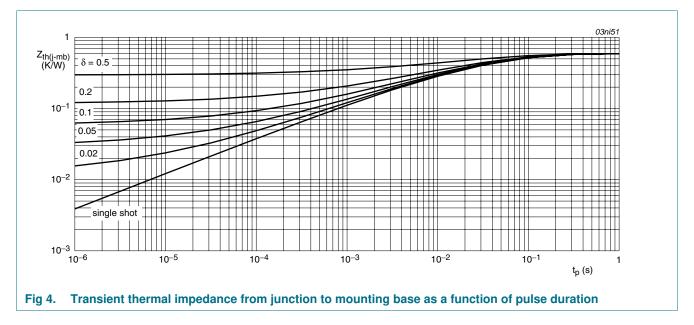


Table C The sum of the sup stanistics

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6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{V}; \text{T}_j = 25 ^\circ\text{C}$	55	-	-	V
	voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
V _{GS(th)} gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 10</u>	1	1.5	2	V	
		$\label{eq:ID} \begin{split} I_D = 1 \mbox{ mA; } V_{DS} = V_{GS}; \mbox{ T}_j = 175 \mbox{ °C}; \\ see \mbox{ Figure 10} \end{split}$	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 10</u>	-	-	2.3	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μA
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μA
I _{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
		V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state	V_{GS} = 10 V; I _D = 25 A; T _j = 25 °C	-	6.4	7.5	mΩ
	resistance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 175 \text{ °C};$ see <u>Figure 11</u> ; see <u>Figure 12</u>	-	-	16	mΩ
		V_{GS} = 4.5 V; I _D = 25 A; T _j = 25 °C	-	-	8.5	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see Figure 11; see Figure 12	-	6.8	8	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	92	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 13</u>	-	11	-	nC
Q _{GD}	gate-drain charge		-	43	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	4551	6021	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 14</u>	-	760	900	рF
C _{rss}	reverse transfer capacitance		-	500	687	рF
t _{d(on)}	turn-on delay time		-	40	-	ns
t _r	rise time		-	175	-	ns
t _{d(off)}	turn-off delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	280	-	ns
t _f	fall time	$R_{G(ext)} = 10 \ \Omega; T_j = 25 \ ^{\circ}C$	-	167	-	ns
L _D	internal drain inductance	from drain lead 6 mm from package to centre of die ; $T_j = 25 \text{ °C}$	-	4.5	-	nH
		from upper edge of drain mounting base to centre of die ; $T_j = 25 \text{ °C}$	-	2.5	-	nH
L _S	internal source inductance	from source lead to source bond pad ; $T_j = 25 \text{ °C}$	-	7.5	-	nH

Characteristics ... continued

Parameter

Table 6.

Symbol

Source-drain diode

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Max

Unit

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Тур

Min

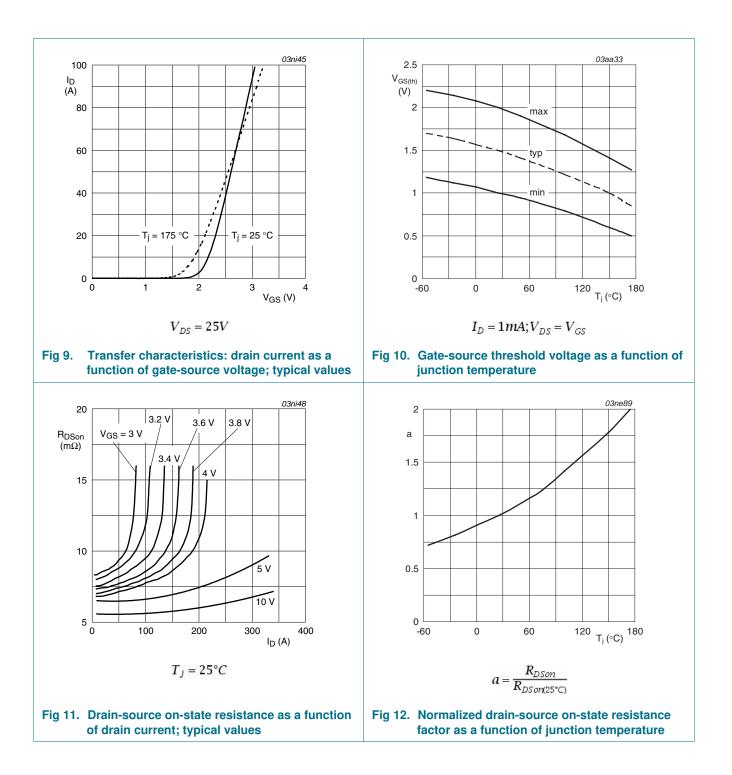
SD	source-drain voltage	I _S = 25 A; V _G see <mark>Figure 15</mark>	5				1.2	V
r	reverse recovery time		/dt = -100 A/µs;		-	70	-	ns
) _r	recovered charge	V _{GS} = -10 V;	$V_{DS} = 25 V; T_j = 2$	25 °C	-	170	-	nC
400 I _D (A) 300 -	10 8 5 label is V _{GS}	03ni47 S (V)	9 R _{DSon} (mΩ) 8				03ni46	
200 -	4.2 4 3.8 3.6		7					
100 -	3.4 3.2 3 2.8 2.6 2.4 2.4 2.2		6					
0		10	5	5		10	15	
	$T_j = 25^{\circ}C; t_p = 300 \mu s$	_{DS} (V)			$25^{\circ}C;I_D$		_{iS} (V)	
	VI	_{DS} (V) rent as a	Fig 6. Drain-s	$T_j =$ source o	$25^{\circ}C;I_D$ n-state ro voltage;	= 25A esistanc	e as a fu	unction
	V_{j} $T_{j} = 25^{\circ}C; t_{p} = 300 \mu s$ Dutput characteristics: drain curr unction of drain-source voltage;	_{DS} (V) rent as a	Fig 6. Drain-s of gate	$T_j =$ source o	n-state re	= 25A esistanc	e as a fu	unction
10 ⁻¹ I _D (A)	V_{j} $T_{j} = 25^{\circ}C; t_{p} = 300 \mu s$ Dutput characteristics: drain curr unction of drain-source voltage;	_{DS} (V) rent as a typical values	Fig 6. Drain-s of gate	$T_j =$ source o	n-state re	= 25A esistanc	e as a fu values	unctior
10 ⁻¹ I _D (A) 10 ⁻² 10 ⁻³ 10 ⁻⁴	$T_{j} = 25^{\circ}C; t_{p} = 300 \mu s$ Dutput characteristics: drain currunction of drain-source voltage;	_{DS} (V) rent as a typical values	Fig 6. Drain-s of gate	$T_j =$ source o	n-state re	= 25A esistanc	e as a fu values	unction
fu 10 ⁻¹ 10 ⁻² 10 ⁻³ 10 ⁻⁴	$T_j = 25^{\circ}C; t_p = 300 \mu s$ Cutput characteristics: drain curput characteristics: drain curp	rent as a typical values	Fig 6. Drain-s of gate	T _j =	n-state revoltage;	= 25A	e as a fu values	
$ \begin{array}{c} 10^{-1} \\ I_D \\ (A) \\ 10^{-2} \\ 10^{-3} \\ 10^{-4} \\ 10^{-5} \\ 10^{-6} \\ 0 \end{array} $	$T_{j} = 25^{\circ}C; t_{p} = 300 \mu s$ Dutput characteristics: drain currunction of drain-source voltage;	rent as a typical values	Fig 6. Drain-s of gate	$T_{j} =$	n-state re voltage;	= 25A esistance typical v $= 25V$	ee as a fu values 03ni44	

Conditions

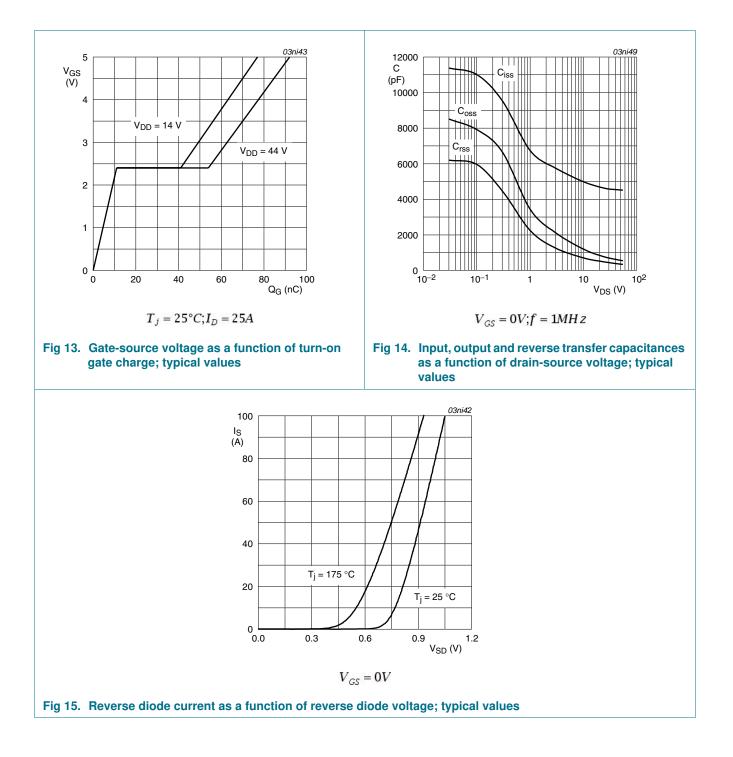
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7. Package outline

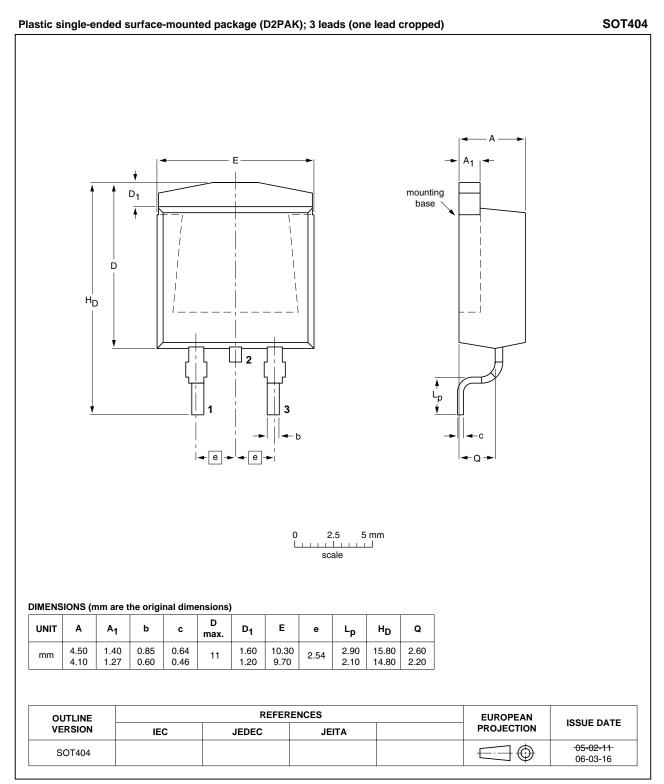


Fig 16. Package outline SOT404 (D2PAK)

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8. Revision history

Table 7. Revision his	story			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK9608-55A v.4	20110131	Product data sheet	-	BUK95_9608_55A v.3
Modifications:		of this data sheet has be miconductors.	en redesigned to comp	bly with the new identity guidelines
	 Legal texts 	have been adapted to the	ne new company name	where appropriate.
	 Type numb 	er BUK9608-55A separa	ated from data sheet B	UK95_9608_55A v.3.
BUK95_9608_55A v.3	20020506	Product data	-	BUK9508_9608-55A v.2

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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